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Facile synthesis of nanostructured Ni/NiO/N-doped graphene electrocatalysts for enhanced oxygen evolution reaction†

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Electrocatalysts containing a Ni/NiO/N-doped graphene interface have been synthesised using the ligand-assisted chemical vapor deposition technique. NiO nanoparticles were used as the substrate to grow N-doped graphene by decomposing vapours of benzene and N-containing ligands. The method was demonstrated with two nitrogen-containing ligands, namely dipyrazino[2,3-*f*:2',3'-*h*]quinoxaline-2,3,6,7,10,11-hexacarbonitrile (L) and melamine (M). The structure and composition of the as-synthesized composites were characterized by XRD, Raman spectroscopy, SEM, TEM and XPS. The composite prepared using the ligand L had NiO sandwiched between Ni and N-doped graphene and showed an overpotential of 292 mV at 10 mA cm⁻² and a Tafel slope of 45.41 mV dec⁻¹ for the OER, which is comparable to the existing noble metal catalysts. The composite prepared using the ligand M had Ni encapsulated by N-doped graphene without NiO. It showed an overpotential of 390 mV at 10 mA cm⁻² and a Tafel slope of 78.9 mV dec⁻¹. The ligand-assisted CVD route demonstrates a facile route to control the microstructure of the electrocatalysts.

success of the technology. Extensive studies on transition metal oxides based on Co,^{1,2} Ni,³⁻⁵ Mn,^{6,7} Fe,⁸ Cu,^{9,10} and Zn¹¹ in the form of simple,¹² doped,¹³⁻¹⁵ and mixed oxides,^{16,17} layered double hydroxides^{18,19} in nanostructured forms,^{20,21} porous architectures²² or nanocomposites²³⁻²⁷ underscore their prominence as economically viable alternatives to noble metal-based electrocatalysts. Conventionally, the nanocomposites of transition metals and oxides with graphene have been attractive as they offered a good electrochemical performance due to high electrical conductivity, surface area, and specific capacitance (2573 F g⁻¹) with low fabrication costs.^{20,21,28-31} Defects in the form of heteroatomic doping on graphene have been shown not only to improve the conductivity but also increase the adsorption of reactants. In recent years, the crucial role of the microstructure of catalysts on the performance has come to the fore. Besides the right composition, the microstructure of an electrocatalyst has been recognized to enhance seamless electronic interaction between its different components, that eventually results in superior reaction kinetics. Particularly, the metal-metal oxide interfaces on electrocatalysts are interesting as they favour the formation of oxygen vacancies, which can activate the reactants, as well as aid in an efficient charge transfer.^{32,33} Considering these results, structured nanocomposites such as metal/metal oxide/N-doped graphene is likely to hold the key to higher efficiency due to favorable chemisorption as well as charge transfer kinetics in the OER.³¹ Although microstructured electrocatalysts are an interesting target, their synthesis in a scalable fashion is a non-trivial subject. Solution-based chemical synthetic routes adopted to obtain such N-doped graphene-metal/metal oxide nanocomposites typically involve the preparation of graphene/graphene oxide or *vice versa* followed by the deposition of metal oxide nanoparticles on its surface, followed by a redox step to obtain the required microstructure. Such methods result in poor interfacial interaction and hence higher performance is not fully recognized. A facile method to synthesize composites with control over the microstructure is critical to realize better OER catalysts. In this work, we have synthesized the composites of Ni/NiO and N-doped

1. Introduction

Electrocatalytic water splitting is a promising and scalable technology to renewably produce green hydrogen. The success of this technology hinges on the development of efficient, low-cost electrocatalysts for the sluggish oxygen evolution reaction (OER). Although noble metals are outstanding in their performance, their high cost is an impediment to the translational

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graphene using the chemical vapor deposition (CVD) technique. In this scalable route, carbon can be intimately deposited on the surface of a substrate due to thermal decomposition of volatile carbon precursors. Among various possible transition metals, Ni was chosen due to the high solubility of carbon in the metal lattice under high temperatures that eventually precipitates on cooling to form graphene. The minimal lattice mismatch between Ni and the graphene is another factor to be considered to avoid lattice strains along the interfaces.^{34–37} The latter has been shown to result in an efficient charge transfer across the interface.^{38,39} Such an advantage is usually sacrificed in other bottom-up chemical synthetic routes, where interfaces are poorly structured.

To obtain the nanostructured catalyst, NiO nanoparticles (ESI) were used as the substrate instead of conventionally employed metallic Ni foil or plates. The NiO nanoparticles have a higher surface area than Ni foil and hence the resultant composite was envisaged to have a higher surface area. Typically, in a CVD method, nitrogen is doped into graphene by passing nitrogen-containing gaseous precursors or vapours of nitrogen containing organic precursors into the hot reaction zone along with the carbon precursor diluted in a carrier gas. Alternatively, solid nitrogen precursors may be sublimed or directly deposited on the substrate.⁴⁰ In this work, the doping of nitrogen was attempted in a single step by vaporizing a solution of nitrogen-containing ligands dissolved in benzene. The vapour of the solution of benzene was generated using a liquid vaporizer and carried to the reaction site with a flow of H₂. The method offers a facile route to control the microstructure of a nanocomposite electrocatalyst.

2. Experimental section

2.1. Materials

All chemicals (nickel nitrate, D-glucose, CTAB, and KOH) were purchased from Sigma-Aldrich. Ni foam was purchased from The Electrode Store, India, with 99.99% purity.

2.2. Preparation of N-doped graphene-decorated nickel nanoparticles

2.2.1 Preparation of NiO/Ni/N-doped graphene. Two N-containing ligands, namely dipyrzino[2,3-*f*:2',3'-*h*] quinoxaline-2,3,6,7,10,11-hexacarbonitrile (L) and melamine (M), were used as nitrogen precursors and benzene was used as the carbon precursor in the CVD. The composite samples prepared using the ligands L and M are referred to as NiFL and NiFMF, respectively. The CVD process consisted of four steps. In the first step, the reaction zone consisting of NiO foam was ramped up to 1273 K for annealing and held at that temperature for 20 min under 10 sccm flow of H₂ to clean up the surface. Following this, the heating zone was cooled down to 1073 K. Typically, 100 mg of L was dissolved in 20 mL of benzene. In the case of ligand M, 1 g of M was dissolved in 20 mL of benzene so as to keep the nitrogen content the same. Both the solutions appeared turbid. In a typical experiment, the solution was vaporized at 353 K and transported using H₂ flow at 50 sccm

over the NiO substrate inside the CVD. The third step was synthesizing the composite, where the reaction over Ni foam was carried out at 1073 K for 30 min, followed by cooling in H₂ gas to form NiFL. Similarly, the reaction was carried out at 1273 K for 30 min before cooling down in H₂ flow to form NiFMF. After the growth time, the temperature of the system was cooled down.

2.3. Characterization

A powder X-ray diffractometer (model: Rigaku Smart Lab XRD) with a Cu K α source ($\lambda = 0.154$ nm) operated at a voltage of 45 kV and a current of 200 mA was used to identify the crystalline phases of the material. The sample scan was done in the range of $2\theta = 10\text{--}90^\circ$ with a step size of 0.02. An FT-IR spectrometer (IR Tracer 100, Shimadzu Scientific Instruments) was used to understand bonding characteristics in N-doped graphene. A Raman spectrophotometer (model: Horiba Labram HR Evo) was used to analyze the spectra in the $100\text{--}3000\text{ cm}^{-1}$ range, employing a 532 nm ULF laser source. The morphology of the samples was characterized using a Field Emission Scanning Electron Microscope (FESEM). The elemental dispersion was confirmed by EDS mapping associated with FE-SEM. The binding energies of the elements present in the catalyst were analyzed by X-ray photoelectron spectroscopy (Thermo Fisher Scientific Instruments UK, model K ALPHA+) with a monochromatic Al K α X-ray source with 6 mA beam current and 12 kV operating voltage. Transmission electron microscopy (TEM) was performed using a Talos 2000S G2 FEG with an EDS detector. High-resolution TEM (HRTEM) pictures and electron diffraction (ED) patterns were analyzed by Gatan GMS 3 software (open source).

2.4. Electrochemical measurements

All electrochemical measurements were performed on a CH electrochemical workstation (CHI 660E). The commercially available Ni foam electrode (0.5 cm^2) was sonicated for 5 min in acetone, 3 M HCl, and deionized water to clean the surface oxide layers. After cleaning, the Ni foam was dried in a vacuum chamber for 6 h at 60 °C. The working electrodes were prepared by drop coating a 10 mg dispersion of each electrocatalyst (NiFL and NiFMF) in a mixture of 1 mL of water and ethanol (1 : 1) and 10 μL of Nafion. After drop coating, the electrodes were vacuum-dried. All electrochemical measurements were performed with a three electrode geometry containing an Ag/AgCl reference electrode and Pt wire as a counter electrode in 1 M KOH (pH = 14) solution. Linear sweep voltammetry (LSV) measurements were conducted at a scan rate of 5 mV s^{-1} in the voltage range of 0 to 1 V *versus* an Ag/AgCl electrode and converted to a reversible hydrogen electrode (RHE) using the following equation (eqn (1)).

$$E(\text{RHE}) = E_{\text{Ag/AgCl}} + 0.05912 \text{ pH} + 0.197 \text{ V} \quad (1)$$

where $E(\text{RHE})$ is the potential for the reversible hydrogen electrode, $E_{\text{Ag/AgCl}}$ is the potential with respect to the Ag/AgCl reference electrode, and the pH of 1 M KOH was measured to be 14. The overpotential values were calculated by subtracting



the theoretical reduction potential of oxygen (1.23 V) from the potential (*versus* RHE) values obtained at the current density of 10 mA cm⁻² for each electrocatalyst. Further, to study the kinetics of the OER, the Tafel slope was calculated by performing linear fitting on the anodic part of the plot obtained from LSV data at a scan rate of 5 mV s⁻¹. Cyclic voltammetry (CV) was performed in non-faradaic regions (−0.12 to +0.12 V *versus* Ag/AgCl electrode) with different scan rates ranging from 2 mV s⁻¹ to 100 mV s⁻¹. From the CV, the current *versus* scan rate graphs were plotted to calculate C_{dl} values and specific capacitance values were calculated by using the formula in eqn (2).

$$C_s = \int IdV/\Delta V \times \nu \times A \quad (2)$$

where ΔV is the voltage window (0.24 V), ν is the scan rate in mV s⁻¹, and A is the area of the electrode (0.5 cm²). Electrochemical active surface area (ECSA) was evaluated by using the following formula: ECSA = C_{dl}/C_s . The TOF was calculated using the formula: TOF = $\frac{I}{2nF}$, where F is the Faraday constant, n is the number of active sites, $n = Q/2F$, calculated by performing CV in the non-faradaic region, and I is current at a specific overpotential. Electrochemical impedance spectroscopy (EIS) was performed at 0.6 V *versus* Ag/AgCl electrode with a potential amplitude of 5 mV in the AC frequency range from 0.1 to 10⁵ Hz.

3. Results and discussion

The molecular structures of ligands L and M that are introduced with an intention to dope nitrogen in the graphene differed in the nature of the nitrogen as well as the nitrogen-to-carbon ratio (Fig. 1a). XRD patterns of the composites NiFL and NiFMF prepared in the presence of the ligands L and M, respectively are shown in Fig. 1b. The peak at $2\theta = 26.2^\circ$ is indexed to graphite (JCPDS No.: 56-0159) in both samples. Particularly, the peak in NiFMF is broadened significantly more compared to NiFL indicating the presence of a fewer layers of graphene in the NiFMF. This intriguing observation can be explained based on the effect of the ligands on the physical properties of the solution of benzene. The concentration-dependent changes to the physical properties of benzene are expected in the presence of solutes such as L or M. The concentration of M was kept significantly high compared to L in order to keep the nitrogen content in the solutions approximately close. Due to this, the boiling point of the benzene solution containing M is expected to be higher compared to that of the solution containing L. As a result, at 353 K, the rate of vaporization of benzene from solution M is likely to be lower compared to that in the solution containing L. Thus, the strong graphitic peak in NiFL is due to the availability of a larger concentration of benzene available for decomposition at the reaction site (in comparison to NiFMF). In addition to the number of layers of graphene, the ligands and their concentration also had a stark influence on the chemical composition of the composite. Peaks at $2\theta = 44.4$, 62.8 , and 76.3° corresponded to metallic nickel (JCPDS No.: 04-0850), and peaks at $2\theta = 37.2$, 43.2 , and 62.8° corresponded to NiO (JCPDS

No.: 01-071-1179). Interestingly, the composition of the composites differed with the ligand employed. NiFL contained Ni, NiO, and graphene, whereas NiFMF contained only Ni and graphene.

Although the substrate is NiO in both cases, the difference in the final composition of the composite hints at the differences in the surface chemical reactions leading to the growth of the graphene. The thermal profile and the reaction atmosphere of H₂ adopted in the synthesis favourably reduces NiO to metallic Ni prior to the starting of the CVD growth. The presence of ligand M in benzene vapour has favored the reduced phase in Ni, even after the completion of the growth of graphene. However, the presence of ligand L in benzene vapour has probably favoured the partial oxidation of the Ni back to NiO. This is likely to be along the interface between the metal and the graphene. The IR spectra shown in Fig. 1c confirmed the presence of nitrogen in graphene with C–N stretches in both NiFL and NiFMF samples.⁴⁴ Consistent with our suspicion that the ligand L may have favored the oxidation of Ni to NiO, the presence of oxygenated species as characterized by the C–O around 1065 cm⁻¹ is stronger in the case of NiFL.

The quality of the graphene was further probed using Raman spectroscopy. In general, the Raman spectrum of the graphene shows three bands (D, G, and 2D bands), characteristic of few-layered graphene. The D and 2D bands are due to second-order double resonance by zone boundary phonons, and the G band is due to the doubly degenerate E_{2g} phonons at the Brillouin zone.⁴¹ The Raman spectrum of NiFL, as shown in Fig. 1d, shows all three bands. In addition to the three bands, NiFL also shows a small shoulder peak around 1610 cm⁻¹, corresponding to the D' band ascribed to the intravalley, defect-induced, double-resonance processes.⁴¹ The fact that the 2D band is present in NiFL suggested a unique structural difference between NiFL and NiFMF. In NiFL, probably NiO is sandwiched between Ni and graphene so that Ni is not in direct contact with the graphene. Importantly, the 2D band in Ni/graphene composites is subdued strongly suggesting a direct contact between Ni and carbon.⁴² Importantly, this band is present in NiFL. Further, in NiFMF, the D and G bands merged, and the 2D band was absent. The higher number of defects causes the D band to have a broader appearance, which consequently leads to its overlap with the G band. The absence of the 2D band also indicates higher defect concentrations⁴³ in graphene. In conclusion, the characterization data suggests that NiFL is a multilayered composite with a Ni/NiO/N-doped graphene structure, while NiFMF is fewer layered, defect-rich, N-doped graphene encapsulating Ni nanoparticles with an interface of Ni/N-doped graphene.

The elemental composition on the surface of NiFL and NiFMF is analyzed using XPS. The O 1s spectra comprised peaks corresponding to three different oxygen species in the sample. Generally, the peak in the range of 527.7–530 eV corresponds to the lattice oxygen (O_L), and the peak in the range of 531.1–532 eV corresponds to the oxygen vacancy (O_V).⁴⁵ In Fig. 2a, the peak for O_V in NiFL is found at 531 eV. The peak at 532.2 eV is ascribed to functionalized oxygen (O_F) such as –COO– or O=C–O on graphene.⁴⁶ In Fig. 2c, the O 1s spectrum of NiFMF is deconvoluted to



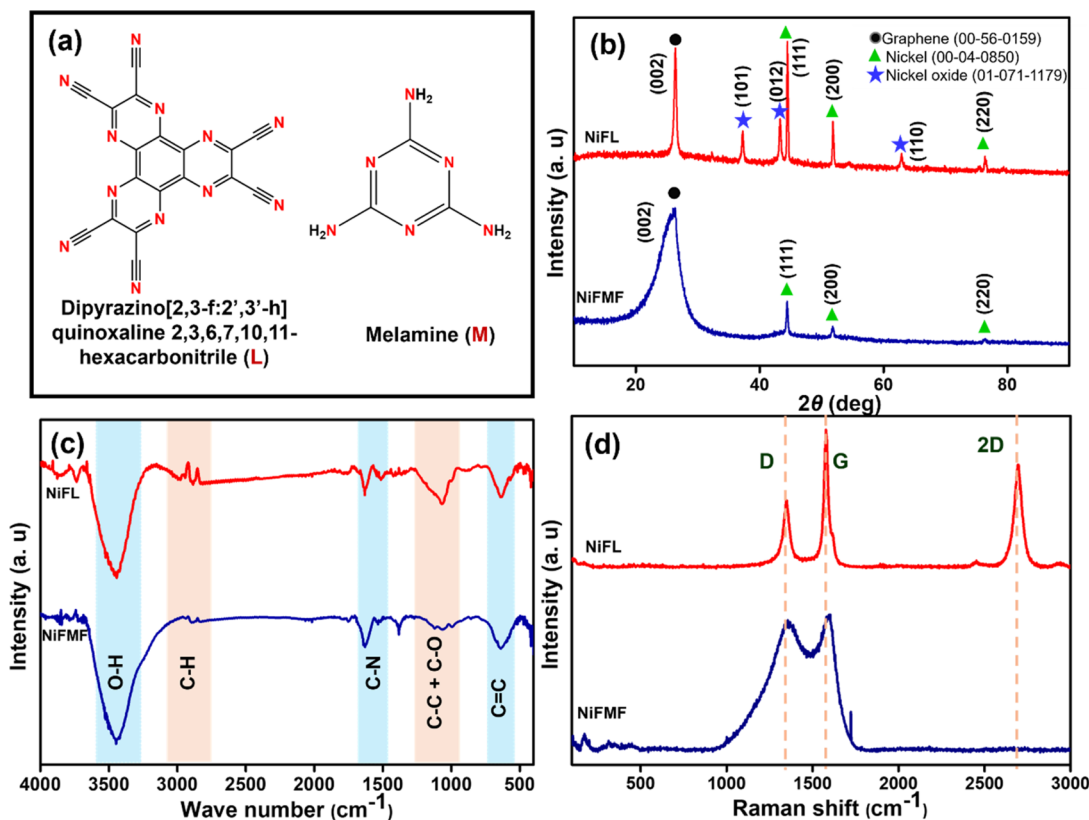


Fig. 1 (a) The molecular structures of the ligands L and M, (b) XRD pattern of NiFL (red) and NiFMF (blue) with ● graphite, ▲ nickel and ★ nickel oxide, (c) IR spectra of NiFL (red) and NiFMF (blue), and (d) Raman spectra of NiFL (red) and NiFMF (blue).

two peaks corresponding to adsorbed oxygen species (O_A) and O_F on carbon. As expected, the peak due to O_V is absent in NiFMF. The C 1s spectra of both samples show signals due to C–N species (285.8 eV) confirming the doping of the nitrogen.⁴⁷ Attempts to record the N 1s spectra to determine the nature of nitrogen in the carbon matrix did not yield satisfactory data in both the cases. This intriguing observation is probably due to the heterogeneity in the concentration of nitrogen in the graphene shell. XPS, being a surface-sensitive technique, gives information on the nitrogen content pertaining to the surface of a few nm (1–5 nm) depth. It is likely that the nitrogen ligand vaporized in larger concentrations during the initial reaction periods. This increases the concentration of N-doping on graphene layers closer to the surface of NiO substrate. As the reaction proceeded, the concentration of the ligands in the vapor phase may have decreased, leading to a decreased doping. This may have resulted in a low concentration of nitrogen on the surface.

Although synthesized under identical conditions, NiFL and NiFMF differed significantly in morphological organization. Fig. 3a is the FESEM image of NiFL on a 30 μm scale. At a higher magnification, the FESEM image of NiFL showed micro ‘flower buds’ (Fig. 3b), with each layer having micro hair-like projections (Fig. 3c) with a size of approximately 50 nm. In contrast, NiFMF has two types of surfaces that can be distinguished easily by the roughness as shown in Fig. 3d. Magnified images of the smoother and rougher surfaces of NiFMF are shown in Fig. 3e and f, respectively. The rougher side shows pillar-like structures

ending in spherical globules of approximately 100 nm in size, while the relatively smoother side has hair-like projections resembling the surface of the NiFL.

TEM images show non-uniform sized particles for both the samples. HRTEM analysis showed high-resolution lattice fringes of NiFL (Fig. 4c) having a d -spacing of 0.208, 0.203, and 0.335 nm corresponding to NiO, Ni, and graphene, respectively. The NiO layer was seen interfacing the Ni and the graphene. In contrast, the d -spacing of fringes in NiFMF (Fig. 4e) consisted of 0.203 and 0.335 nm, corresponding to Ni and graphene, respectively. The SAED pattern appeared to be of well-crystallized NiO and metallic nickel for NiFL and NiFMF, respectively. The rings were indexed to (111), (200), and (220) of NiO in NiFL (Fig. 4d) and (111) and (200) of Ni in NiFMF (Fig. 4f). The structure as deduced in the spectroscopic and diffraction studies (Fig. 1b–d) was consistent with the microscopic (TEM and HRTEM) studies (Fig. 4).

The elemental distributions of both samples and their TEM images are shown in Fig. 5a–j. Unlike XPS, the elemental information under TEM comes from greater depths from the surface due to deeper penetration of the electron beam. In NiFL, signals due to oxygen and nickel are co-located. The localized signal indicated that O is present as oxide ions (NiO). As seen in Fig. 5c, the localization of Ni and O is stronger in NiFL, supporting the observation that the O is due to NiO. On the other hand, the O signal in NiFMF is randomly distributed. The dispersion of elements O, C, and N is uniform across the



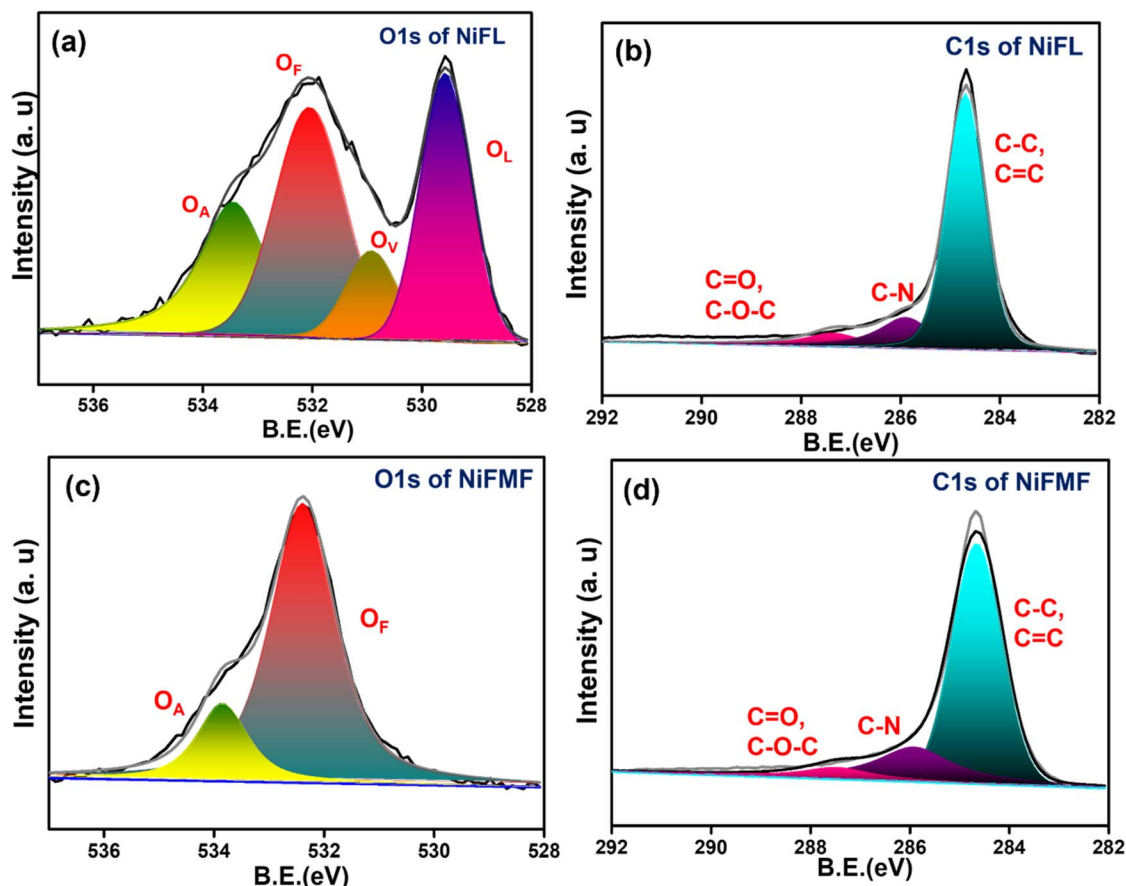


Fig. 2 XPS spectra of NiFL and NiFMF. (a) O 1s of NiFL and (b) C 1s of NiFL. (c) O 1s of NiFMF and (d) C 1s of NiFMF.

samples in NiFMF, suggesting their origin from the functionalization of the graphene matrix. Also, the N signal appeared stronger for NiFMF than NiFL, which is not expected considering the higher nitrogen-to-carbon ratio in L than M. But apart from the ratio, other factors like the solubility of ligands in benzene, the fraction of ligands in the vapor phase, and the

decomposition rate of these compounds over nickel contribute to the spatial variation of N-doping in the core-shell structure.

The interaction between Ni and graphene can be confirmed from the spectrum. From the Raman spectrum, the absence of the 2D band of graphene is conspicuous in NiFMF as compared to NiFL. It has been shown that a strong interaction between Ni

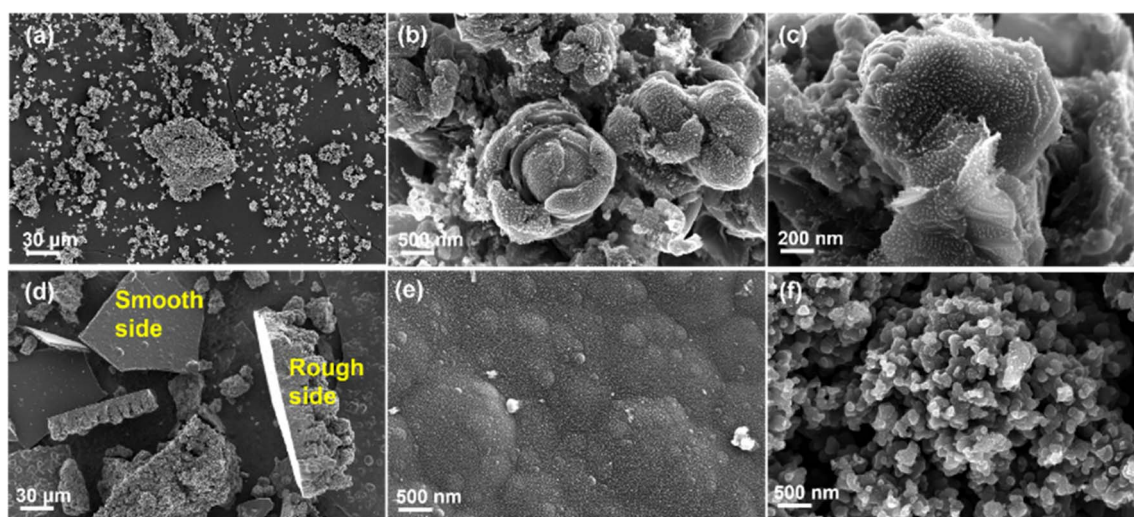


Fig. 3 FESEM images of NiFL and NiFMF. Images (a), (b) and (c) correspond to NiFL, and images (d), (e), and (f) correspond to NiFMF at comparable magnifications. Images e and f show the smoother and rougher surfaces of NiFMF, respectively.



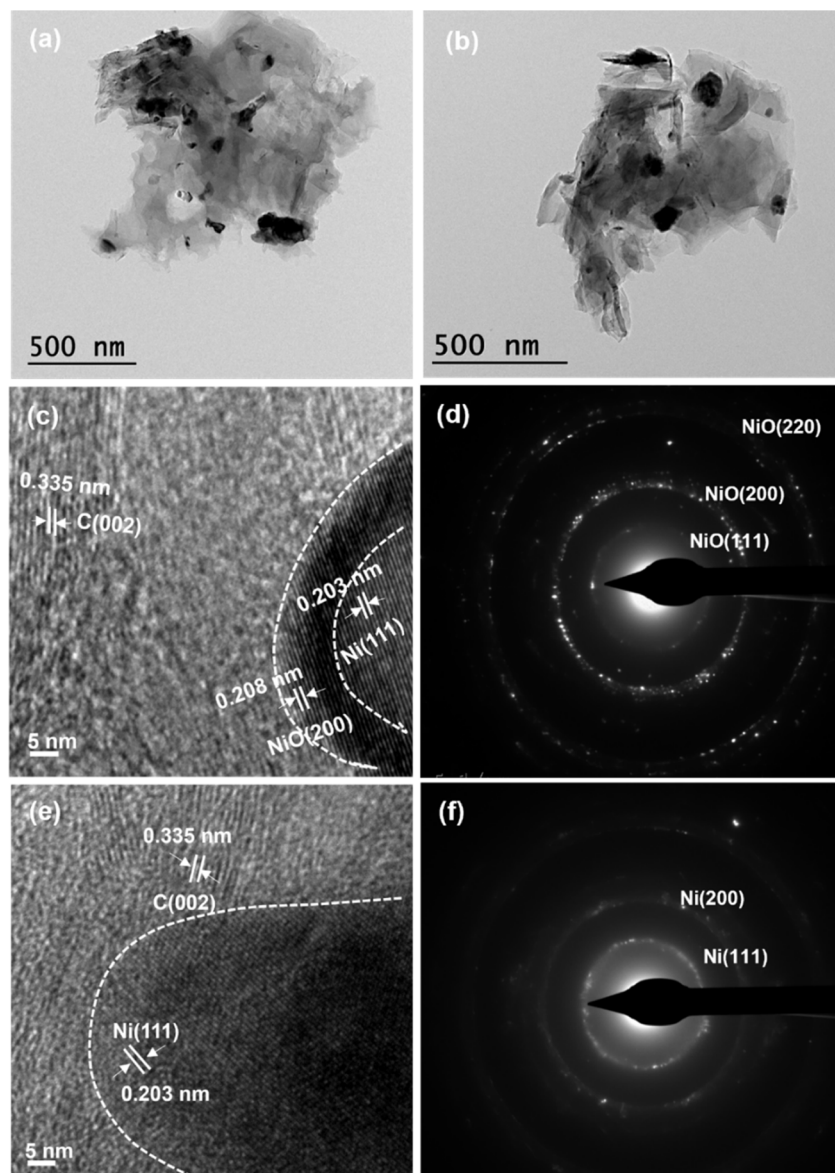


Fig. 4 TEM image of NiFL (a) and NiFMF (b). HRTEM images and SAED patterns of NiFL ((c) and (d), respectively) and NiFMF ((e) and (f), respectively).

3d and C 2p states modifies the graphene's Dirac cone near the Fermi level which in turn alters the resonant condition of Raman scattering.³⁴ The vanishing of the 2D band can be taken as evidence for strong electronic interaction between metallic nickel and graphene. Interestingly, a strong 2D band is seen in the Raman spectrum of NiFL, where metallic Ni and graphene are separated by NiO supporting our conclusion.

After understanding the difference in the structures of NiFL and NiFMF, both were subjected to electrochemical studies. The LSV measurements of all electrodes are depicted in Fig. 6a. Interestingly, NiFL shows a sharp increase in current density as compared to NiFMF. Moreover, the discernible peak at 1.46 V *vs.* RHE in NiFL can be attributed to the reduction of NiO. Correspondingly, the CV measurements within a voltage window of 1.0–1.7 V *versus* RHE mirror the same peak at 1.46 V *versus* RHE, confirming the reversible redox reaction of NiO within NiFL

(Fig. S1(a)†). The electrocatalyst NiFL exhibited a superior OER performance compared to NiFMF. The overpotential values at 10 mA cm⁻² for NiFL and NiFMF were 292 mV and 390 mV, respectively. The Tafel plot derived from the LSV recorded at 5 mV s⁻¹ and linearly fitted to study the efficiency of electrocatalysts over time (Fig. 6b) revealed a Tafel slope value for NiFL ~56% lower (~45 mV dec⁻¹) than NiFMF (~79 mV dec⁻¹). This difference stemmed from the higher kinetic activity of the surface-active catalytic sites of NiO in NiFL indicating better OER performance.

The overpotential and Tafel slope of the OER electrocatalyzed by various Ni-based catalysts are provided in Table 1. The Ni/NiO/N-doped graphene described in this work has one of the lowest overpotentials reported, suggesting the role of the microstructure. These enhancements are attributed to the well-crystallized NiO and oxygen vacancies within NiFL. The



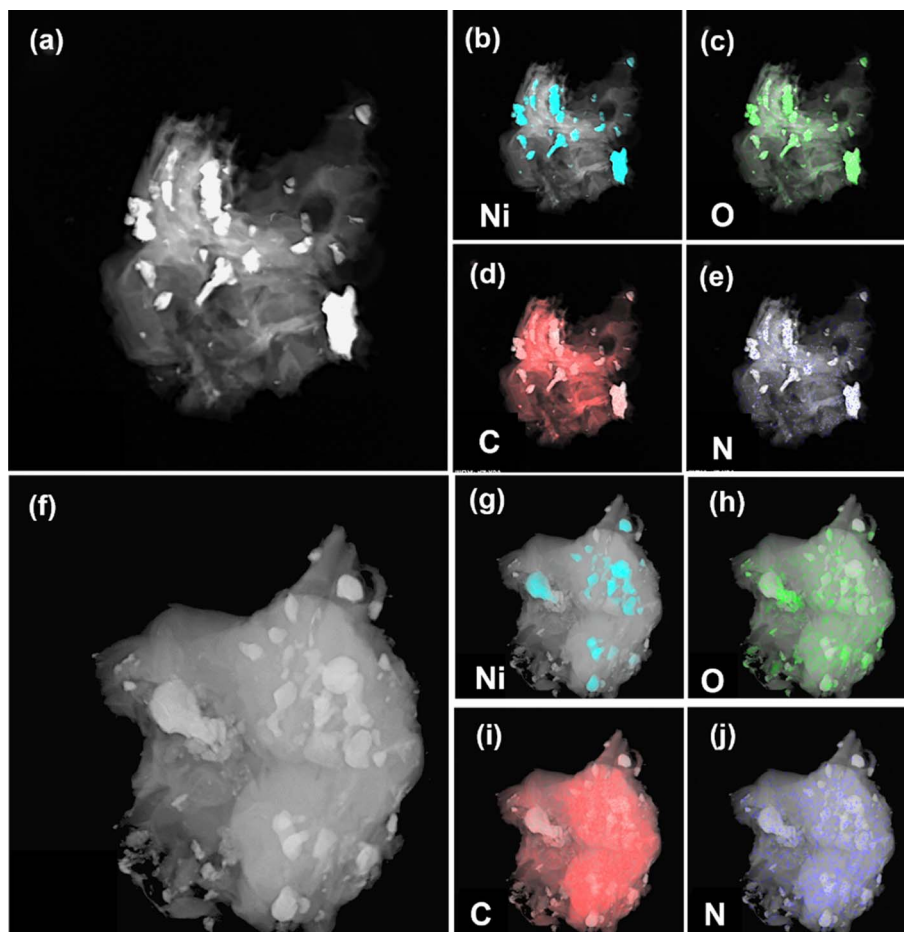


Fig. 5 TEM image and elemental distribution of NiFL (a–e) and NiFMF (f–j). The signals corresponding to the elements are light blue (Ni), green (O), red (C), and dark blue (N).

homogeneous distribution of NiO within graphitic carbon flakes in NiFL imparts greater efficiency for the OER, surpassing recently reported graphitic C/NiO electrocatalysts.^{54,55} The electrochemically active surface area (ECSA) is determined by performing the CVs in the non-faradaic regions from -0.12 V to $+0.12$ V (*versus* Ag/AgCl) at different scan rates ranging from 2 to 100 mV s^{-1} (Fig. S1(b) and (c)†). The double-layer capacitance (C_{dl}) values are examined to understand the active surface area responsible for OER activity. NiFL exhibited a significantly higher C_{dl} value (1.427 mF) than that of NiFMF (0.854 mF), as seen in Fig. 6d. While the ECSA values ($\text{ECSA} = C_{dl}/C_s$) of NiFL and NiFMF are nearly the same (0.223 cm^2 and 0.211 cm^2 , respectively), the micro-flower bud morphology of NiFL, featuring micro-hairs on each layer of graphene flakes and uniformly distributed NiO, contributed to its superior performance over NiFMF. Turnover frequency (TOF) values for NiFL and NiFMF are 5.17 s^{-1} and 3.73 s^{-1} at 420 mV, respectively,⁵⁶ highlighting the heightened kinetic reactivity of NiFL for the OER. Impedance measurements were conducted at 1.63 V (*versus* RHE) to measure the resistances involved during the oxygen evolution. The resulting net resistances are obtained as a sum of electrolytic resistance (R_s) and charge transfer resistance (R_{ct}). In the case of NiFL, a lower net resistance of ~ 3.4 Ω

indicated faster OER (Fig. 6d). The stability of NiFL is rigorously assessed through a 48 hour chronopotentiometry test at a current density of 20 mA cm^{-2} (Fig. 6f). Surprisingly, a 4% reduction in the overpotential for NiFL is observed over this duration, signifying that NiFL behaves as an even better electrocatalyst with time. This high stability of NiFL may be attributed to the unique core-shell structure in Ni/NiO/graphene in contrast to polycrystalline NiFMF. Video S1† visually depicts the rigorous oxygen evolution from the NiFL electrode at 20 mA cm^{-2} , with no significant loss of catalyst observed during oxygen evolution for 48 h, indicating the firm adhesion of the electrocatalyst onto the Ni foam substrate. The unique core-shell structure of Ni/NiO/graphene in NiFL likely contributes to its superior electrocatalytic performance with intrinsic carbon and oxygen defects, further enhancing the activity of graphitic carbon with heteroatom defects.³⁰ As the OER has been shown to proceed *via* the Mars-van Krevelen mechanism in the literature,³² oxygen vacancies created due to the Ni/NiO interface and functionalized oxygen groups in the material are shown to play a crucial role in enhancing the oxygen evolution reaction on NiFL.

In order to understand the stability of the catalysts, the LSV and CV measurements were carried out for the fresh sample



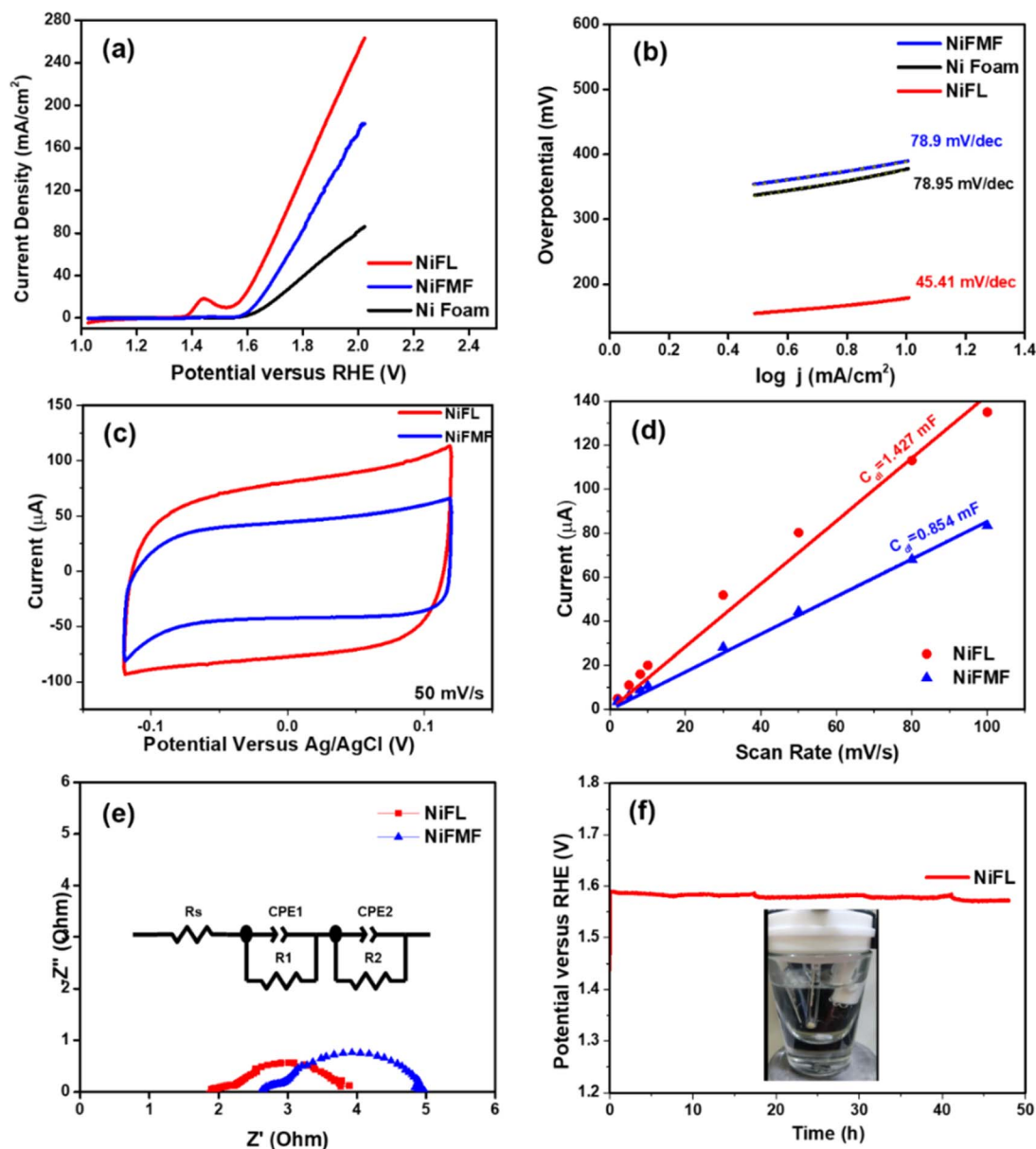


Fig. 6 (a) Linear sweep voltammetry (LSV) curves at 5 mV s^{-1} , (b) corresponding Tafel plot, (c) comparison of CVs for 50 mV s^{-1} with (d) C_{dl} calculation, (e) Nyquist plots of different electrocatalysts at 0.6 V versus Ag/AgCl in 1 M KOH solution, (f) chronopotentiometric stability test of NiFL at 20 mA cm^{-2} for 48 h.

Table 1 Table containing overpotential and Tafel slope values of nickel-based composites for the OER in the literature^{48–53}

Sl no.	Material	Overpotential @ 10 mA cm^{-2} (mV)	Tafel slope (mV dec^{-1})	Reference
1	NiO supported on NF	310	54	48
2	NiO nanosheets	340	97	49
3	Ni/NiO _x	390	70	50
4	Ni@NiO/N-C nanowires	390	100	51
5	Ni/NiO/N-doped activated carbon	346	70	52
6	Ni-NiO@3-dimensional hierarchical porous graphene	1640	55	53
7	Ni/NiO/N-doped graphene	292	45	This work

and after 48 h (Fig. S2†). The electrode was found to be highly stable even after 48 h of testing based on the redox peaks. A slight improvement in the performance was noticeable, probably due to improvement in the wettability of the electrode. The XPS of Ni 2p and O 1s of NiFL before reaction (a and c) and after cycling tests (b and d) are provided in Fig. S3.† The deconvoluted Ni 2p spectrum of NiFL (before reaction) showed peaks corresponding to Ni(OH)₂ and Ni²⁺ (NiO). However, Ni(OH)₂ could not be detected in the XRD, probably due to its existence confined to a few atomic layers along the surface. The deconvoluted peaks could be identified at B.E. values of 854.13 eV, 856.03 eV, 858.18 eV, 861.59 eV, 872.13 eV, 873.67 eV, 876.38 eV, and 880.38 eV corresponding to Ni²⁺ 2p_{3/2}, Ni(OH)₂ satellite, of Ni(OH)₂ satellite, of Ni²⁺ 2p_{3/2}, Ni²⁺ 2p_{1/2}, Ni(OH)₂ satellite, of Ni²⁺ 2p_{1/2}, and satellite of Ni(OH)₂, respectively. Table S1 provided in the ESI† lists the peak positions of these peaks for similar composites reported in the literature.^{51–53,57,58} It confirms that a shift towards higher binding energies is commonly reported in the position of Ni 2p peaks when interaction between Ni and N-doped carbon occurs. Signals due to Ni⁰ could not be observed in the freshly prepared NiFL probably due to its presence at deeper levels. After carrying out 100 cycles of testing, the Ni 2p spectrum showed peaks corresponding to Ni⁰ in addition to Ni²⁺ (NiO) and Ni(OH)₂ suggesting partial migration of Ni⁰ from the core to the surface. The B.E. peaks could be indexed to 852.27 (Ni⁰), 854.28 (Ni²⁺ 2p_{3/2}), 856.23 (Ni(OH)₂), 859.25 (sat Ni⁰), 861.74 (sat Ni²⁺ 2p_{3/2}), 864.24 (sat Ni(OH)₂), 867 (Ni⁰), 873.63 (Ni²⁺ 2p_{1/2}), 878.82 (shakeup of β-Ni(OH)₂), 880.62 (shakeup of α-Ni(OH)₂) and 882.2 (sat. Ni²⁺ 2p_{1/2}).^{57,59} The O 1s spectra also showed a small shift to the higher binding energy region after the cycling tests. The migration of Ni⁰ to the surface is also corroborated by the decrease in the intensity of the O_L and increase in the intensity of O_V.

4. Conclusion

Ni/NiO encapsulated with N-doped graphene (NiFL) and Ni encapsulated with N-doped graphene (NiFMF) were synthesized using a facile and scalable ligand-assisted CVD method. The method made it convenient to control the microstructure of the nanocomposite by changing the nature as well as the concentration of the ligands. Using two types of ligands (L and M) in the L-CVD N-doped graphene on Ni or Ni/NiO was obtained. The structure-sensitivity of the NiFL and NiFMF in the OER was studied. Ni/NiO/N-doped graphene (NiFL) was a superior electrocatalyst with an overpotential of 292 mV at 10 mA cm⁻² and a Tafel slope of 45.41 mV dec⁻¹, comparable to noble metal catalysts. On the other hand, Ni/N-doped graphene (NiFMF) showed relatively lower electrocatalytic performance. The unique microstructure and compositional difference created using the ligand-assisted CVD method resulted in significantly different electrocatalytic activity in the OER.

Conflicts of interest

The authors declare no conflicts of interest.

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